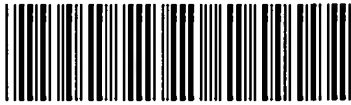


Search Notes

Application/Control No.

10/713,044

Examiner

Thien F. Tran

Applicant(s)/Patent under
Reexamination

IPPOSHI ET AL.

Art Unit

2811

SEARCHED

Class	Subclass	Date	Examiner
257	106, 212	7/15/2005	TT
257	347, 371	7/15/2005	TT
257	653, 654	7/15/2005	TT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR